

Test Report

(EN 50155 & EN 50121-3-2)

Report No.: CEBDBO-WTW-P22070664-1

Test Model: RCX-2750R-PEG

Received Date: 2022/7/22

Test Date: 2022/8/11 ~ 2022/8/27

Issued Date: 2022/9/21

Applicant: Vecow Co., Ltd.

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Table of Contents

Release	Control Record	. 4
1 Cer	tificate of Conformity	. 5
2 Sur	nmary of Test Results	. 6
2.1 2.2 2.3	Performance Criteria Measurement Uncertainty Modification Record	9
3 Ger	neral Information	10
3.1 3.2 3.3 3.4 3.5	Description of EUT Features of EUT Operating Modes of EUT and Determination of Worst Case Operating Mode Test Program Used and Operation Descriptions Primary Clock Frequencies of Internal Source	.10 .11 .11 .11
4 Cor	nfiguration and Connections with EUT	12
4.1 4.2	Connection Diagram of EUT and Peripheral Devices Configuration of Peripheral Devices and Cable Connections	
5 Cor	nducted Disturbance at Auxiliary a.c. or d.c. Power Ports	18
5.1 5.2 5.3 5.4	Limits Test Instruments Test Arrangement Test Results	.18 .19
6 Rad	diated Disturbance up to 1 GHz	22
6.1 6.2 6.3 6.4	Limits Test Instruments Test Arrangement Test Results	.22 .23
7 Rac	diated Disturbance above 1 GHz	26
7.1 7.2 7.3 7.4	Limits Test Instruments Test Arrangement Test Results	.27 .28
8 Har	monics Current Measurement	31
8.1 8.2 8.3 8.4 8.5	Limits Classification of Equipment Test Instruments Test Arrangement Test Results	.31 .31 .32
9 Vol	tage Fluctuations and Flicker Measurement	34
9.1 9.2 9.3 9.4	Limits Test Instruments Test Arrangement Test Results	.34 .34
10 Ele	ctrostatic Discharge Immunity Test (ESD)	
10.1 10.2 10.3 10.4	Test Specification Test Instruments Test Arrangement Test Results	.36 .37



11 R	adio-frequency Electromagnetic Field Immunity Test (RS)	43
11.1	Test Specification	43
11.2	Test Instruments	44
11.3	Test Arrangement	
11.4	Test Results	45
12 E	lectrical Fast Transient/Burst Immunity Test (EFT)	46
12.1	Test Specification	46
12.2	Test Instruments	
12.3	Test Arrangement	
12.4	Test Results	
13 S	urge Immunity Test	49
13.1	Test Specification	49
13.2	Test Instruments	49
13.3	Test Arrangement	
13.4	Test Results	50
14 In	nmunity to Conducted Disturbances Induced by RF Fields (CS)	51
14.1	Test Specification	51
14.2	Test Instruments	
14.3		
	Test Arrangement	53
14.4	Test Arrangement Test Results	53
14.4		53 54
14.4	Test Results	53
14.4 15 P i	Test Results	
14.4 15 P 15.1	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz	
14.4 15 P 15.1 15.2	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement	
14.4 15 P 15.1 15.2 15.3 15.4 15.5	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD)	53 54 55 55 55 56 57 58 58 58
14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS)	53 54 55 55 55 56 57 58 58 58 58 59
14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6 15.7	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS) Fast Transients (EFT)	53 54 55 55 55 56 57 57 58 58 58 58 59 60
14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6 15.7 15.8	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS) Fast Transients (EFT) Surge	53 54 55 55 55 56 57 57 58 58 58 59 60 62
14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6 15.7	Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS) Fast Transients (EFT)	53 54 55 55 55 56 57 57 58 58 58 59 60 62



Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P22070664-1	Original release.	2022/9/21



1 Certificate of Conformity

Product:	AI Computing System
Brand:	Vecow
Test Model:	RCX-2750R-PEG
Series Model:	RCX-2XXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXX
Sample Status:	Engineering sample
Applicant:	Vecow Co., Ltd.
Test Date:	2022/8/11 ~ 2022/8/27
Standards:	EN 50155:2017, Clause 13.4.8
	EN 61000-3-2:2014, Class D
	EN IEC 61000-3-2:2019 +A1:2021, Class D
	EN 61000-3-3:2013 +A2:2021
	EN 50121-1:2017
	EN 50121-3-2:2016
	EN 61000-4-2:2009
	EN 61000-4-3:2006 +A1:2008 +A2:2010
	EN IEC 61000-4-3:2020
	EN 61000-4-4:2012
	EN 61000-4-5:2014 +A1:2017
	EN 61000-4-6:2014 +AC:2015

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :	Vivian Ch	n du en / Senior Specialist	_ , Date:	2022/9/21
Approved by :	Jim Hsiang / As	HSian g sociate Technical Manager	_ , Date:	2022/9/21
Report No.: CEBDBO-WTW-P2	22070664-1	Page No. 5 / 65		Report Format Version: 6.1.2



2 Summary of Test Results

EN 50121-3-2:2016, Emission requirements, EN 50155:2017, Clause 13.4.8				
Port	Result/Remarks	Verdict		
Auxiliary a.c. or d.c. power ports - Auxiliary supply sinusoidal a.c. or d.c.	Conducted disturbance 150 kHz- 500 kHz: 99 dBµV quasi-peak 500 kHz- 30 MHz: 93 dBµV quasi-peak	Minimum passing margin is -56.80 dB at 12.57561 MHz	Pass	
Auxiliary a.c. or d.c. power ports – AC power outlet port for public use	Conducted disturbance 50 Hz- 2 kHz: THD <8% (THD: total harmonic distortion)	Test not applicable because the port does not exist.	N/A	
Battery referenced ports - Battery power supply	Conducted disturbance 150 kHz- 500 kHz: 99 dBµV quasi-peak 500 kHz- 30 MHz: 93 dBµV quasi-peak	Test not applicable because the port does not exist.	N/A	
Enclosure	Radiated disturbance 30 MHz- 230 MHz: 40 dBµV/m quasi-peak 230 MHz -1 GHz: 47 dBµV/m quasi-peak	Minimum passing margin is -5.78 dB at 216.03 MHz	Pass	
Enclosure	Radiated disturbance 1 GHz- 3 GHz: 76 dBµV/m peak 56 dBµV/m average 3 GHz - 6 GHz: 80 dBµV/m peak 60 dBµV/m average	Minimum passing margin is -6.88 dB at 5400.03 MHz	Pass	

Emission requirements					
Standard	Test Item / specifications	Result/Remarks	Verdict		
EN 61000-3-2:2014 EN IEC 61000-3-2:2019+A1:2021	Harmonic current emissions	Class D	Pass		
EN 61000-3-3:2013+A2:2021	Voltage fluctuations and flicker	$\begin{array}{ll} P_{st} \leqq 1.0 & d_{max} \leqq 4\% \\ P_{lt} \leqq 0.65 & d_c \leqq 3.3\% \\ T_{max} \leqq 500 ms \end{array}$	Pass		



	EN 50121-3-2:2016, Immunity requirements, EN 50155:2017, Clause 13.4.8					
Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict	
3.1	EN 61000-4-6:2014 +AC:2015	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass	
3.2	EN 61000-4-4:2012	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Fast Transients (EFT) 5/50 (t _r /t _w) ns, 5kHz ±2kV Performance Criterion A	Performance Criterion A	Pass	
3.3	EN 61000-4-5:2014 +A1:2017	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Surges 1.2/50 (8/20) $(T_f/T_d) \mu s$ Line to ground: ±2kV 42 Ω , 0.5 μF Line to line: ±1kV 42 Ω , 0.5 μF Performance Criterion B	Performance Criterion A	Pass	
4.1	EN 61000-4-6:2014 +AC:2015	Signal & communication, process measurement & control ports	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass	
4.2	EN 61000-4-4:2012	Signal & communication, process measurement & control ports	Fast Transients (EFT) 5/50 (t _r /t _w) ns, 5kHz ±2kV, Capacitive clamp Performance Criterion A	Performance Criterion A	Pass	
5.1	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field amplitude modulated (RS) ¹ , 80% AM (1kHz) 80-800 MHz, 20V/m Performance Criterion A	Performance Criterion A	Pass	
5.2	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field from digital mobile telephones (RS) ² , 80% AM (1kHz) 800-1000 MHz, 20V/m 1400-2000 MHz, 20V/m 2000-2700 MHz, 5V/m 5100-6000 MHz, 3V/m Performance Criterion A	Performance Criterion A	Pass	



EN 50121-3-2:2016, Immunity requirements, EN 50155:2017, Clause 13.4.8						
Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict	
5.3	EN 61000-4-2:2009	Enclosure ports	Electrostatic Discharges (ESD) ±6kV Contact discharge ±8kV Air discharge Performance Criterion B	Performance Criterion B	Pass	
Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.						

Note 2: For large apparatus (e.g. traction drives, auxiliary converters) it is often not practical to perform the immunity test to radiated electromagnetic fields on the complete unit. In such cases the manufacturer should test susceptible sub-systems (e.g. control electronics). The test report should justify the selection or not of sub-systems and any assumptions made (e.g. reduction of field due to case shielding).

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.

The above EN basic standards are applied with latest version if customer has no special requirement.
 Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

4. N/A: Not Applicable



2.1 Performance Criteria

General Performance Criteria

The general performance criteria apply for those ports for which no specific performance criteria are defined (e.g. auxiliary ports) in the report.

Performance criterion A: The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion B: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion C: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted disturbance at mains port using AMN, 150kHz ~ 30MHz	3.00 dB	3.4 dB (<i>U</i> _{cispr})
Radiated disturbance, 30MHz ~ 1GHz	4.30 dB	6.3 dB (<i>U</i> _{cispr})
Radiated disturbance, 1GHz ~ 6GHz	4.64 dB	5.2 dB (<i>U</i> _{cispr})

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

2.3 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 Description of EUT

Product	AI Computing System
Brand	Vecow
Test Model	RCX-2750R-PEG
Series Model	RCX-2XXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXX
Model Difference	For marketing purpose.
Sample Status	Engineering sample
Operating Software	WIN 10 PRO, Burnintest V9.2
Power Supply Rating	DC from Adapter
Accessory Device	N/A
Data Cable Supplied	N/A

Note:

The EUT uses following adapter.

Brand	LITEON		
Model	PA-1331-92E		
Input Power	100-240V, 50-60Hz, 4.4A		
Output Power	+24V, 13.75A, 330W		
Device Line	AC (3-Pin) cable (1.8m)		
Power Line	DC cable (1.0m) with two ferrite cores.		

3.2 Features of EUT

- 1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
- 1. The EUT configured with the following key components:

Components	Brand	Model	Specification
CPU	Intel	i7-11700	Intel® Core™ i7-11700 Processor
RAM	INNODISK	M4S0-AGS 105IK-H03	16GB DDR4 2666 W/T SODIMM
DRAM	VECOW	VMD4NIT-08G00A	8GB DDR4-2666-19 SODIMM WT
SSD	INNODISK	DES25-A28M41BW1DC-H03	128GB 2.5" SATA SSD 3ME4



3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

- The EUT is designed with AC power of rating 100-240Vac, 50-60Hz. For radiated emission evaluation, 230Vac/50Hz (for EN 50155), 120Vac/60Hz (for FCC Part 15) had been covered during the pre-test. The worst data was found at 230Vac/50Hz and recorded in the applied test report.
- 2. Test modes are presented in the report as below.

Mode	Test Condition	Input Power
А	Full System	230Vac/ 50Hz

3.4 Test Program Used and Operation Descriptions

Emission tests (Harmonics & Flicker excluded):

- a. Turned on the power of all equipments.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages to/ from SSD, and ext. HDDs.
- d. IP camera captured video / audio signal to EUT.
- e. EUT sent and received ping messages to/ from the Notebook PCs (kept in a remote area) via two STP LAN cables (10m each).
- f. EUT sent "H" messages to ext. LCD monitors. Then they displayed "H" messages on their screens simultaneously.
- g. EUT sent "1kHz audio" signal to earphone.
- h. EUT sent messages to printer and printed them out.
- i. Steps c-h were repeated.

Harmonics & Flicker & Immunity tests:

- a. Turned on the power of all equipments.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages to/ from SSD, and USB Flash.
- d. IP camera captured video / audio signal to EUT.
- e. EUT sent and received ping messages to/ from the Notebook PCs (kept in a remote area) via two STP LAN cables (10m each).
- f. EUT sent "color bars with moving element" messages to ext. LCD monitors. Then they displayed "color bars with moving element" messages on their screens simultaneously.
- g. EUT sent audio signal to speaker.
- h. Steps c-g were repeated.

3.5 Primary Clock Frequencies of Internal Source

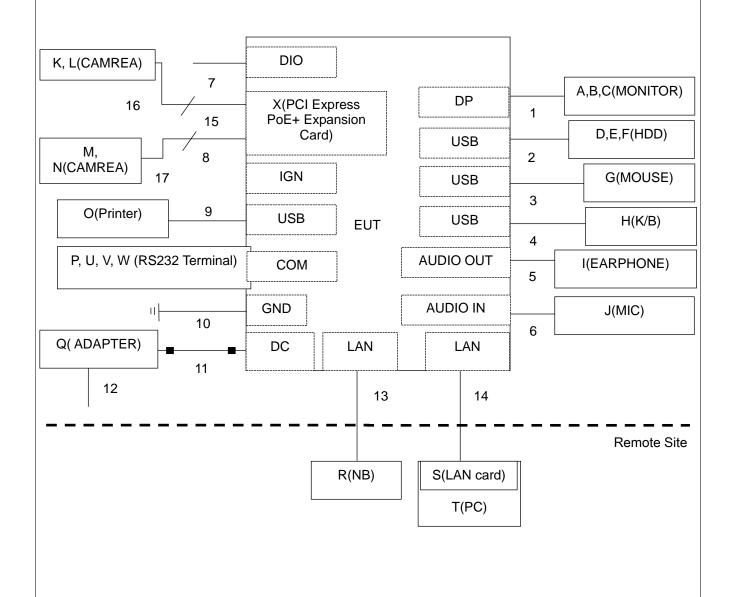
The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 2.5GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.



4 Configuration and Connections with EUT

4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):





Harmonics & Flicker & Immunity tests: 13 1 DP*3 DIO 2 A,B,C (MONITOR*3) 6 DIO 1 USB3.1 * 4 F,G,H,I (USB Flash*4) P,Q,R , 16 7 (POE IP CAMREA*3) W(PCI Express PoE+ 2 Expansion Card) D (USB K/B) USB 3.1 14 / 15 S (POE IP 3 CAMREA) USB 3.1 E (USB M/S) EUT IGN 4 AUDIO OUT L,M,N,O(RS232 Terminal*4) COM*4 J(SPEAKER) 5 8 GND AUDIO IN K(MIC) EUT ADAPTER DC IN LAN(1G) LAN(2.5G) 9 10 12 11 Remote Site V(LAN Card) T(NB) U(PC)



4.2	Configuration of Peripheral Devices and Cable Connections
	Configuration of r cripheral Devices and Cable Conficutions

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
А	Monitor	ASUS	VG289Q	M1LMTF385740	NA	M1-010634
В	Monitor	ASUS	VG289Q	M1LMTF385742	NA	M1-010635
С	Monitor	ASUS	VG289Q	M1LMTF385832	NA	M1-010637
D	USB 3.1 SSD	Crucial	CT500X8SSD9	1941E320114D	NA	H4-010856
Е	USB 3.1 SSD	Crucial	CT500X8SSD9	1943E3201B6D	NA	H4-010859
F	USB 3.1 SSD	Crucial	CT500X8SSD9	1940E3200CFB	NA	H4-010849
G	USB Mouse	DELL	MOCZUL	CN-049TWY-PR C00-77B-007E	NA	M4-010884
Н	USB Keyboard	Dell	KB216t	CN-0W33XP-LO 300-7CL-1909	NA	K1-010798
Ι	EARPHONE	PHILIPS	SBC HL145	N/A	NA	H2-010180
J	Microphone	E-books	E-EPB099	N/A	NA	M5-010144
Κ	IP CAMARA	3MP	MBL030A-ORZ0310	NA	DOC	Supplied by applicant
L	IP CAMARA	3MP	MBL030A-ORZ0310	NA	DOC	Supplied by applicant
М	IP CAMARA	3MP	MBL030A-ORZ0310	NA	DOC	Supplied by applicant
Ν	IP CAMARA	3MP	MBL030A-ORZ0310	NA		Supplied by applicant
0	Printer	HP	HP Officejet Pro 251dW	NA	B94SDGOB11 91	Provided by Lab
Ρ	RS232 Terminal	N/A	NA	N/A	NA	Supplied by applicant
Q	ADAPTER	LITEON	PA-1331-92E	N/A	NA	Supplied by applicant
R	Laptop	LENOVO	T480	PF1EZSAW	NA	N1-010484
S	10G LAN card	ASUS	XG-C100C	NA	DoC	Provided by Lab
Т	PC	DELL	3010 SF	1JWQS02	NA	Provided by Lab
U	RS232 Terminal	N/A	NA	N/A	NA	Supplied by applicant
V	RS232 Terminal	N/A	NA	N/A	NA	Supplied by applicant
W	RS232 Terminal	N/A	NA	N/A	NA	Supplied by applicant
x	PCI Express PoE+ Expansion Card	Vecow	PE-2004MX	NA	NA	Supplied by applicant

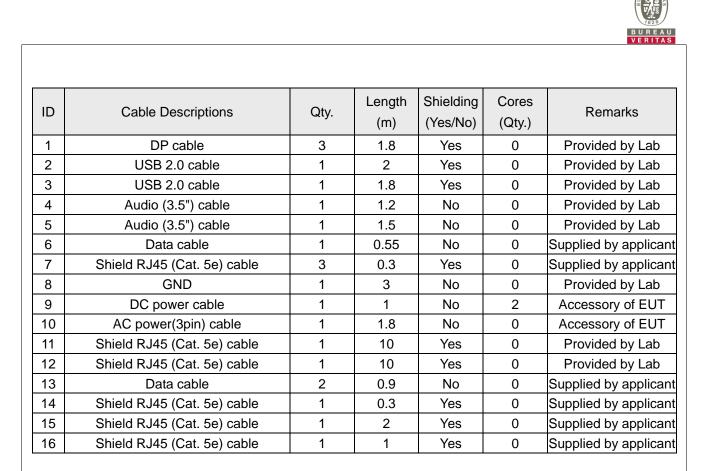


ID	Cable Descriptions	Qty.	Length	Shielding	Cores	Remarks
		α.γ.	(m)	(Yes/No)	(Qty.)	rtomanto
1	DP cable	3	1.8	Yes	0	Provided by Lab
2	USB Type A to C cable	3	1	Yes	0	Provided by Lab
3	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
4	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
5	Audio (3.5") cable	1	1.2	No	0	Provided by Lab
6	Audio (3.5") cable	1	2	No	0	Provided by Lab
7	DIO cable	2	1	No	0	Provided by Lab
8	RJ45 (Cat. 5e) cable	2	2	Yes	0	Supplied by applicant
9	USB cable	1	1.5	Yes	0	Provided by Lab
10	GND (PE) cable	1	1.5	No	0	Provided by Lab
11	DC power cable	1	1	No	2	Supplied by applicant
12	AC power cable	1	1.8	No	0	Accessory of EUT
13	RJ45 (Cat. 5e) cable	1	10	Yes	0	Provided by Lab
14	RJ45 (Cat. 5e) cable	1	10	Yes	0	Provided by Lab
15	RJ45 (Cat. 5e) cable	2	1	Yes	0	Supplied by applicant
16	RJ45 (Cat. 5e) cable	2	0.1	Yes	0	Supplied by applicant
17	RJ45 (Cat. 5e) cable	2	0.1	Yes	0	Supplied by applicant



ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
А	Monitor	Vita	VT-270JTG2	204270JTFE001	DoC	Provided by Lab
В	Monitor	DELL	P2415Qb	CN-OGTTPW-74261-662- OAGL	N/A	Provided by Lab
С	Monitor	DELL	P2415Qb	CN-OGTTPW-74261-662- OAAL	N/A	Provided by Lab
D	USB K/B	Microsoft	1576	N/A	N/A	Provided by Lab
Е	USB M/S	Microsoft	MSK-1113(B)	N/A	N/A	Provided by Lab
F	USB 3.0 Dongle	HP	x750w	N/A	N/A	Provided by Lab
G	USB 3.0 Dongle	HP	x750w	N/A	N/A	Provided by Lab
Н	USB 3.0 Dongle	HP	x750w	N/A	N/A	Provided by Lab
Ι	USB 3.0 Dongle	HP	x750w	N/A	N/A	Provided by Lab
J	Speaker	N/A	N/A	N/A	N/A	Provided by Lab
Κ	Microphone	V-COOL	M2/MIC01	N/A	N/A	Provided by Lab
L	RS232 Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
М	RS232 Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
Ν	RS232 Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
0	RS232 Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
Ρ	POE IP CAMARA	3MP	MBL030A-ORZ0310	N/A	DOC	Supplied by applicant
Q	POE IP CAMARA	3MP	MBL030A-ORZ0310	N/A	DOC	Supplied by applicant
R	POE IP CAMARA	3MP	MBL030A-ORZ0310	N/A	DOC	Supplied by applicant
s	POE IP CAMARA	3MP	MBL030A-ORZ0310	N/A	DOC	Supplied by applicant
Т	Laptop	DELL	P41G	FT4W952	N/A	Provided by Lab
U	PC	DELL	OptiPlex 390SF Base	F3PVWBX	N/A	Provided by Lab
V	10G LAN card	ASUS	XG-C100C	N/A	DoC	Provided by Lab
W	PCI Express PoE+ Expansion Card	Vecow	PE-2004MX	NA	NA	Supplied by applicant

Harmonics, Flicker, Immunity tests:





5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports

5.1 Limits

Frequency (MHz)	Quasi-peak, (dBuV)
0.15 - 0.5	99
0.5 - 30	93

Notes: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

5.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
50 ohm terminal	0900510	E1-011285	2021/10/1	2022/9/30
LYNICS	0900510	E1-011286	2021/10/1	2022/9/30
50 Ohms Terminator LYNICS	0900510	E1-01-305	2022/2/9	2023/2/8
Attenuator STI	STI02-2200-10	NO.3	2021/10/22	2022/10/21
Coupling/Dcoupling Network	CDNE-M2	00097	2022/6/1	2023/5/31
Schwarzbeck	CDNE-M3	00091	2022/6/1	2023/5/31
Coupling/Dcoupling Network TESEQ	CDN A201A	44601	2021/12/22	2022/12/21
DC LISN		100219	2022/8/2	2023/8/1
R&S	ESH3-Z6	844950/018	2022/8/2	2023/8/1
DC LISN Schwarzbeck	NNLK 8121	8121-808	2022/4/29	2023/4/28
Isolation Transformer Erika Fiedler	D-65396	017	2021/9/9	2022/9/8
LISN	3825/2	9204-1964	2022/6/17	2023/6/16
ЕМСО	3623/2	9504-2359	2022/8/2	2023/8/1
LISN		101195	2022/8/1	2023/7/31
R&S	ENV216	101196	2022/5/24	2023/5/23
NGO		101197	2022/7/5	2023/7/4
	NNLK 8121	8121-731	2022/5/26	2023/5/25
LISN Schwarzbeck	ININLIN O I Z I	8121-00759	2021/8/17	2022/8/16
Schwarzbeck	NNLK8129	8129229	2022/6/8	2023/6/7
Receiver R&S	ESCI	100412	2021/8/26	2022/8/25
RF Coaxial Cable Commate	5D-FB	Cable-CO3-01	2021/9/15	2022/9/14
Software BVADT	Cond_V7.3.7.4	N/A	N/A	N/A

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

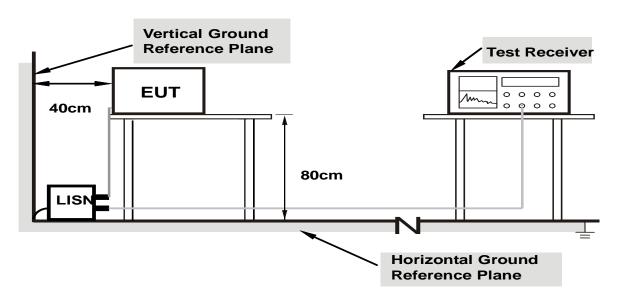
2. The test was performed in Linkou Conduction 3.

3. Tested Date: 2022/8/11



5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: Support units were connected to second LISN.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



5.4 Test Results

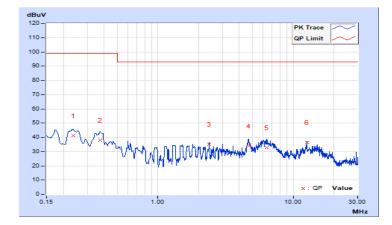
Mode A

Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	26°C, 70% RH
Tested by	Ed. Lin		

	Phase Of Power : Line (L)								
No	Frequency	Correction Factor	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)			
	(MHz)	(dB)	Q.P.	Q.P.	Q.P.	Q.P.			
1	0.23604	9.65	31.47	41.12	99.00	-57.88			
2	0.37293	9.67	28.49	38.16	99.00	-60.84			
3	2.39110	9.75	25.41	35.16	93.00	-57.84			
4	4.66730	9.80	24.30	34.10	93.00	-58.90			
5	6.38840	9.83	22.78	32.61	93.00	-60.39			
6	12.57561	9.90	26.28	36.18	93.00	-56.82			

Remarks:

- 1. Q.P. is abbreviations of quasi-peak individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

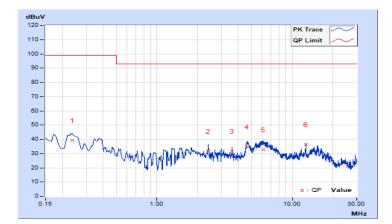


Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	26°C, 70% RH
Tested by	Ed. Lin		

	Phase Of Power : Neutral (N)								
No	Frequency	Correction Factor	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)			
	(MHz)	(dB)	Q.P.	Q.P.	Q.P.	Q.P.			
1	0.23586	9.65	29.62	39.27	99.00	-59.73			
2	2.39501	9.76	21.93	31.69	93.00	-61.31			
3	3.59178	9.79	21.76	31.55	93.00	-61.45			
4	4.64775	9.81	24.99	34.80	93.00	-58.20			
5	6.13419	9.84	22.87	32.71	93.00	-60.29			
6	12.57561	9.96	26.24	36.20	93.00	-56.80			

Remarks:

- 1. Q.P. is abbreviations of quasi-peak individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





6 Radiated Disturbance up to 1 GHz

6.1 Limits

Frequency (MHz)	dBuV/m (at 10m) / quasi-peak
30 - 230	40
230 - 1000	47

Notes: 1. The lower limit shall apply at the transition frequencies.

2. Emission level $(dBuV/m) = 20 \log Emission level (uV/m)$.

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

6.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
ADT. Tower	AT100	0205	N/A	N/A
ADT. Turn Table	TT100	0205	N/A	N/A
Attenuator Mini-Circuits	UNAT-5+	PAD-ST2-01	2021/10/22	2022/10/21
Bi-log Broadband Antenna Schwarzbeck	VULB9168	9168-303	2021/10/29	2022/10/28
Coupling/Dcoupling Network	CDNE-M2	00097	2022/6/1	2023/5/31
Schwarzbeck	CDNE-M3	00091	2022/6/1	2023/5/31
Preamplifier Agilent	8447D	2944A11062	2022/2/16	2023/2/15
Pre_Amplifier EMCI	EMC9135	980711	2022/3/19	2023/3/18
Pre_Amplifier HP	8447D	2944A08313	2022/2/16	2023/2/15
RF Coaxial Cable Pacific	8D-FB	Cable-ST2-01	2021/10/22	2022/10/21
Software BVADT	Radiated_V7.6.15.9.5	N/A	N/A	N/A
TEST RECEIVER	ESCS 30	100276	2022/4/19	2023/4/18
R&S	E303 30	100292	2021/9/1	2022/8/31

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

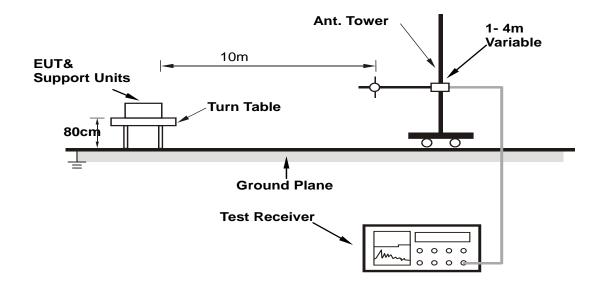
2. The test was performed in Linkou Open Site2, The test site validated date: 2022/7/16 (NSA)

3. Tested Date: 2022/8/12



6.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.
- Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



6.4 Test Results

Mode A

Frequency Range	30 MHz ~ 1 GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120 kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	33°C, 69% RH
Tested By	Paul Chen		

	Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	51.17	28.37 QP	40.00	-11.63	4.00 H	150	37.10	-8.73	
2	124.93	29.64 QP	40.00	-10.36	4.00 H	304	39.35	-9.71	
3	216.03	33.36 QP	40.00	-6.64	4.00 H	189	43.58	-10.22	
4	324.15	40.77 QP	47.00	-6.23	3.27 H	228	46.11	-5.34	
5	450.00	36.19 QP	47.00	-10.81	2.16 H	78	38.99	-2.80	
6	500.00	37.71 QP	47.00	-9.29	1.87 H	108	39.51	-1.80	
7	550.14	38.71 QP	47.00	-8.29	1.75 H	260	39.42	-0.71	
8	662.48	38.21 QP	47.00	-8.79	1.31 H	139	36.17	2.04	

Remarks:

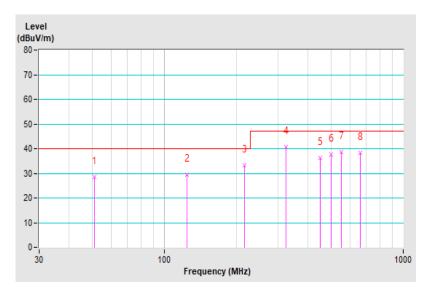
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





Frequency Range	30 MHz ~ 1 GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120 kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	33°C, 69% RH
Tested By	Paul Chen		

	Antenna Polarity & Test Distance : Vertical at 10 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	33.48	28.85 QP	40.00	-11.15	1.23 V	100	38.97	-10.12
2	71.76	28.05 QP	40.00	-11.95	1.78 V	166	39.46	-11.41
3	125.01	33.65 QP	40.00	-6.35	1.00 V	114	43.33	-9.68
4	165.04	31.39 QP	40.00	-8.61	1.00 V	277	39.14	-7.75
5	216.03	34.22 QP	40.00	-5.78	1.00 V	113	44.44	-10.22
6	297.00	35.98 QP	47.00	-11.02	1.00 V	201	42.17	-6.19
7	324.15	37.02 QP	47.00	-9.98	1.00 V	194	42.36	-5.34
8	500.02	33.05 QP	47.00	-13.95	1.00 V	304	34.85	-1.80
9	662.48	33.92 QP	47.00	-13.08	3.27 V	292	31.88	2.04

Remarks:

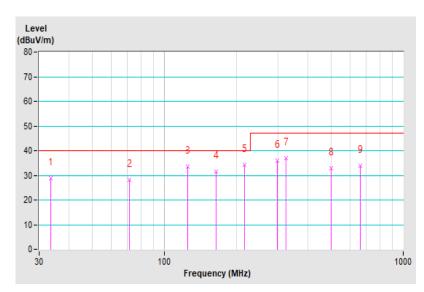
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





7 Radiated Disturbance above 1 GHz

7.1 Limits

	dBuV/m (at 3m)				
Frequency (GHz)	Average	Peak			
1 to 3	56	76			
3 to 6	60	80			

Notes: 1. The lower limit shall apply at the transition frequencies.

2. Emission level (dBuV/m) = 20 log Emission level (uV/m).

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Frequency Range (For unintentional radiators)

Highest frequency generated or used in the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less



7.2 Test Instruments

Model No. Serial No.		Calibrated Date	Calibrated Until
BW-K3-2W44+	PAD-CH7-03	2022/7/7	2023/7/6
BW-N4W5+	PAD-CH10-02	2022/7/7	2023/7/6
BRM17690	005	2022/5/26	2023/5/25
BAF-01	9	N/A	N/A
3115	6714	2021/11/14	2022/11/13
3117-PA	00215857	2021/11/14	2022/11/13
BBHA 9170	212	2021/10/13	2022/10/12
BRC50703-01	010	2022/5/26	2023/5/25
8449B	3008A01292	2022/2/17	2023/2/16
EMC0126545	980076	2022/2/17	2023/2/16
EMC184045B	980235	2022/2/17	2023/2/16
EM102-KMKM-3.5+1M	EM102-KMKM-3.5+1M-02	2022/7/7	2023/7/6
Radiated_V8.7.08	N/A	N/A	N/A
NOODOR	MY60110438	2021/12/8	2022/12/7
N9020B	MY60112260	2022/5/21	2023/5/20
E4446A	MY51100009	2022/6/27	2023/6/26
N9038A	MY51210137	2022/6/9	2023/6/8
MF7802	MF780208216	N/A	N/A
	BW-K3-2W44+ BW-N4W5+ BRM17690 BAF-01 3115 3115 3117-PA BBHA 9170 BRC50703-01 8449B EMC0126545 EM102-KMKM-3.5+1M Radiated_V8.7.08 N9020B E4446A N9038A	BW-K3-2W44+ PAD-CH7-03 BW-N4W5+ PAD-CH10-02 BRM17690 005 BAF-01 9 3115 6714 3117-PA 00215857 BBHA 9170 212 BRC50703-01 010 8449B 3008A01292 EMC0126545 980076 EMC184045B 980235 EM102-KMKM-3.5+1M EM102-KMKM-3.5+1M-02 Radiated_V8.7.08 N/A MY60110438 MY60110438 N9020B MY60110438 N9038A MY51210137	Model No. Serial No. Date BW-K3-2W44+ PAD-CH7-03 2022/7/7 BW-N4W5+ PAD-CH10-02 2022/7/7 BRM17690 005 2022/5/26 BAF-01 9 N/A 3115 6714 2021/11/14 3117-PA 00215857 2021/11/14 BBHA 9170 212 2021/10/13 BRC50703-01 010 2022/5/26 8449B 3008A01292 2022/2/17 EMC0126545 980076 2022/2/17 EM102-KMKM-3.5+1M EM102-KMKM-3.5+1M-02 2022/7/7 Radiated_V8.7.08 N/A N/A N9020B MY60110438 2021/12/8 MY60112260 2022/5/21 2022/5/21 E4446A MY51100009 2022/6/27 N9038A MY51210137 2022/6/9

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

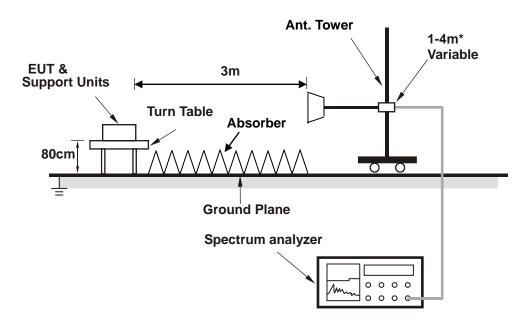
2. The test was performed in Linkou 966 Chamber 3 (CH 10).

3. Tested Date: 2022/8/13



7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.
- Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



7.4 Test Results

Mode A

Frequency Range	1GHz ~ 6GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	25°C, 71% RH
Tested By	Adam Chen		

	Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	1325.07	55.13 PK	76.00	-20.87	1.05 H	158	58.95	-3.82	
2	1325.07	47.69 AV	56.00	-8.31	1.05 H	158	51.51	-3.82	
3	2132.29	51.06 PK	76.00	-24.94	1.00 H	198	51.85	-0.79	
4	2132.29	36.98 AV	56.00	-19.02	1.00 H	198	37.77	-0.79	
5	2399.86	54.23 PK	76.00	-21.77	1.29 H	205	54.15	0.08	
6	2399.86	37.25 AV	56.00	-18.75	1.29 H	205	37.17	0.08	
7	2979.62	51.43 PK	76.00	-24.57	1.54 H	111	49.38	2.05	
8	2979.62	37.89 AV	56.00	-18.11	1.54 H	111	35.84	2.05	
9	3721.31	55.69 PK	80.00	-24.31	1.00 H	1	50.63	5.06	
10	3721.31	42.01 AV	60.00	-17.99	1.00 H	1	36.95	5.06	
11	5400.03	60.31 PK	80.00	-19.69	2.37 H	106	52.52	7.79	
12	5400.03	53.12 AV	60.00	-6.88	2.37 H	106	45.33	7.79	

Remarks:

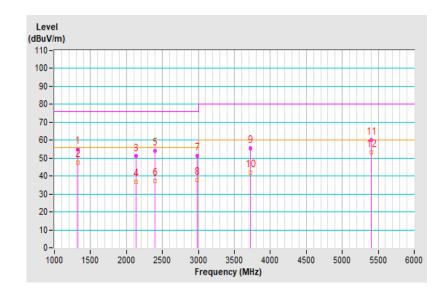
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

– Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





Frequency Range	1GHz ~ 6GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	25°C, 71% RH
Tested By	Adam Chen		

	Antenna Polarity & Test Distance : Vertical at 3 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1324.98	60.12 PK	76.00	-15.88	2.58 V	359	63.95	-3.83
2	1324.98	47.98 AV	56.00	-8.02	2.58 V	359	51.81	-3.83
3	1844.24	50.63 PK	76.00	-25.37	2.34 V	10	52.40	-1.77
4	1844.24	35.86 AV	56.00	-20.14	2.34 V	10	37.63	-1.77
5	2400.07	55.68 PK	76.00	-20.32	1.29 V	204	55.60	0.08
6	2400.07	37.31 AV	56.00	-18.69	1.29 V	204	37.23	0.08
7	2981.33	55.76 PK	76.00	-20.24	1.12 V	354	53.70	2.06
8	2981.33	47.43 AV	56.00	-8.57	1.12 V	354	45.37	2.06
9	4000.04	55.63 PK	80.00	-24.37	1.61 V	153	50.31	5.32
10	4000.04	39.89 AV	60.00	-20.11	1.61 V	153	34.57	5.32
11	5399.85	59.04 PK	80.00	-20.96	2.62 V	113	51.25	7.79
12	5399.85	52.13 AV	60.00	-7.87	2.62 V	113	44.34	7.79

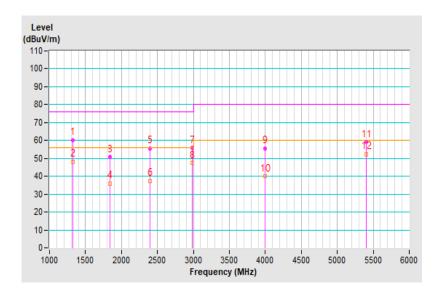
Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





8 Harmonics Current Measurement

8.1 Limits

Limits fo	or Class A equipment		Limits for Class D equi	pment
Harmonic Order	Max. permissible harmonics current	Harmonic Order	Max. permissible harmonics current per	Max. permissible harmonics current
n	A	n	watt mA/W	A
	Odd harmonics		Odd Harmonics on	у
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n
E	ven harmonics			
2	1.08			
4	0.43			
6	0.30			
8≦n≦40	0.23 x 8/n			

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

 According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

8.2 Classification of Equipment

			Olass D
Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D;	equipment which is		W of the following types:
Tools excluding portable tools;	not professional		Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).

8.3 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2022/6/8	2023/6/7
Software	CTS 4	N/A	N/A	N/A

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

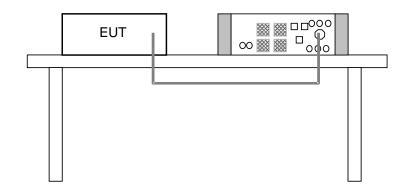
2. The test was performed in Linkou EMS Room No.1.

3. Tested Date: 2022/8/25



8.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



8.5 Test Results

Mode A

Test Duration	5 min	Fundamental Voltage / Ampere	230.65 Vrms / 0.656 Arms
Power Consumption	130.3 W	Power Frequency	50 Hz
Power Factor	0.887	Environmental Conditions	24°C, 75% RH
Tested By	Joey Liu		

Harm#	Harms (avg) (A)	100% Limit (A)	Harms (max) (A)	150% Limit (A)
1	0.586	-	1.643	-
3	0.167	0.443	0.179	0.665
5	0.050	0.248	0.054	0.371
7	0.028	0.130	0.035	0.195
9	0.018	0.065	0.024	0.098
11	0.015	0.046	0.020	0.068
13	0.013	0.039	0.017	0.059
15	0.018	0.034	0.024	0.051
17	0.023	0.030	0.027	0.045
19	0.002	0.026	0.004	0.040
21	0.008	0.024	0.010	0.036
23	0.007	0.022	0.008	0.033
25	0.007	0.020	0.009	0.030
27	0.012	0.019	0.014	0.028
29	0.004	0.017	0.005	0.026
31	0.009	0.016	0.010	0.024
33	0.005	0.015	0.008	0.023
35	0.007	0.014	0.010	0.021
37	0.002	0.014	0.003	0.020
39	0.005	0.013	0.006	0.019

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.



9 Voltage Fluctuations and Flicker Measurement

9.1 Limits

Test item	Limit	Note
Pst	1.0	Pst: short-term flicker severity.
Pit	0.65	Plt: long-term flicker severity.
T _{max} (ms)	500	$T_{max:}$ maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d _c .
d _{max} (%)	4	d _{max:} maximum absolute voltage change during an observation period.
d _c (%)	3.3	dc maximum steady state voltage change during an observation period.

9.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2022/6/8	2023/6/7
Software	CTS 4	N/A	N/A	N/A

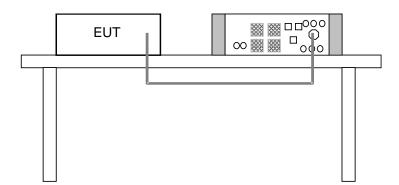
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Linkou EMS Room No.1.
- 3. Tested Date: 2022/8/25

9.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



9.4 Test Results

Mode A

Observation (Tp)	10 min		
Input Power	230 Vac, 50 Hz	Environmental Conditions	24°C, 75% RH
Tested By	Joey Liu		

Test Parameter	Measurement Value	Limit	Remarks
Pst	0.356	1.00	Pass
Plt	0.155	0.65	Pass
T _{max} (ms)	0.000	500	Pass
d _{max} (%)	0.000	4.00	Pass
d _c (%)	0.000	3.30	Pass

Notes:

a. P_{st} means short-term flicker indicator.

b. P_{lt} means long-term flicker indicator.

c. T_{max} means accumulated time value of d(t) with a deviation exceeding 3.3 %.

d. d_{max} means maximum relative voltage change.

e. dc means maximum relative steady-state voltage change.

10 Electrostatic Discharge Immunity Test (ESD)

10.1 Test Specification	
Basic Standard:	EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: ±2, ±4, ±8kV (Direct) Contact Discharge: ±2, ±4, ±6kV (Indirect & Direct)
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

10.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
ESD Generator EM Test	Dito//DM-150/330//DM-150/330-rfci	P1315117252/P1317117852	2022/7/7	2023/7/6

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou ESD Room No.03.

3. Tested Date: 2022/8/27



- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

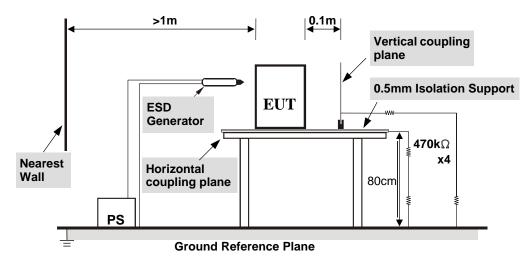


TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940k Ω total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



10.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	24°C, 44% RH, 1000 mbar		

Test Results of Direct Application						
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion	
2	+/-	1~6,20~26,36~40	Note 1		А	
4, 6	+/-	1~6,20~26,36~40	Note 2		В	
2, 4	+/-	7~19,27~35,41,42		Note 1	А	
8	+/-	7~8,35,41,42		Note 1	А	
8	+/-	9~19,27~34		Note 2	В	

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application					
Discharge Polarity Test Point Horizontal Vertical Coupling Performance					Performance
Level (kV)	(+/-)	(+/-) Plane Coupling Plane Plane Criterion			
2, 4, 6 +/- Four Side Note 1 Note 1 A					

3. Right side

Description of test points of indirect application:

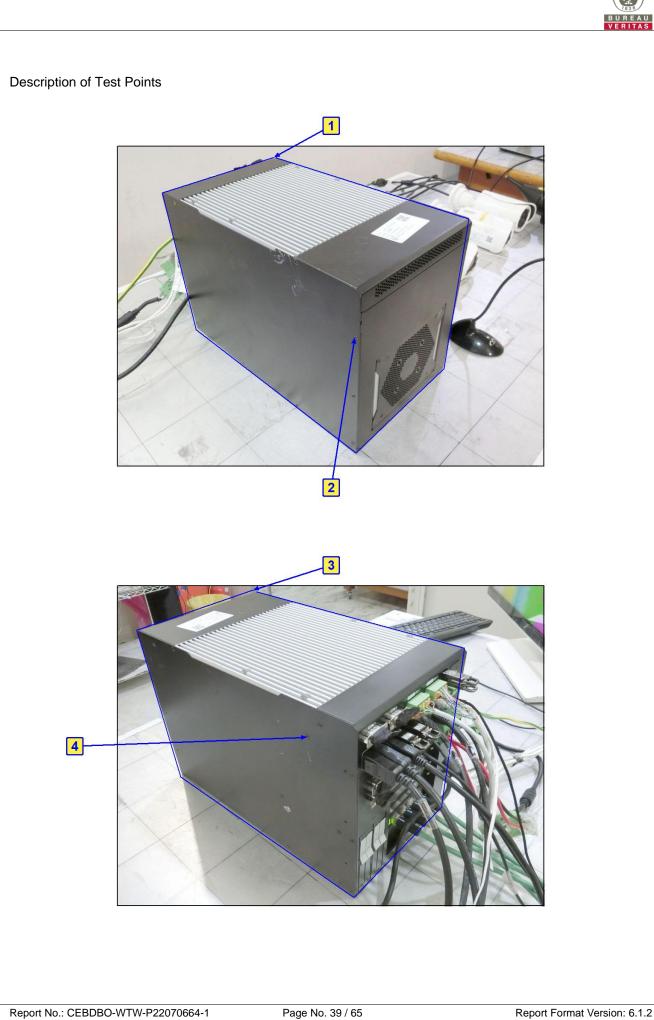
1. Front side 2

2. Rear side

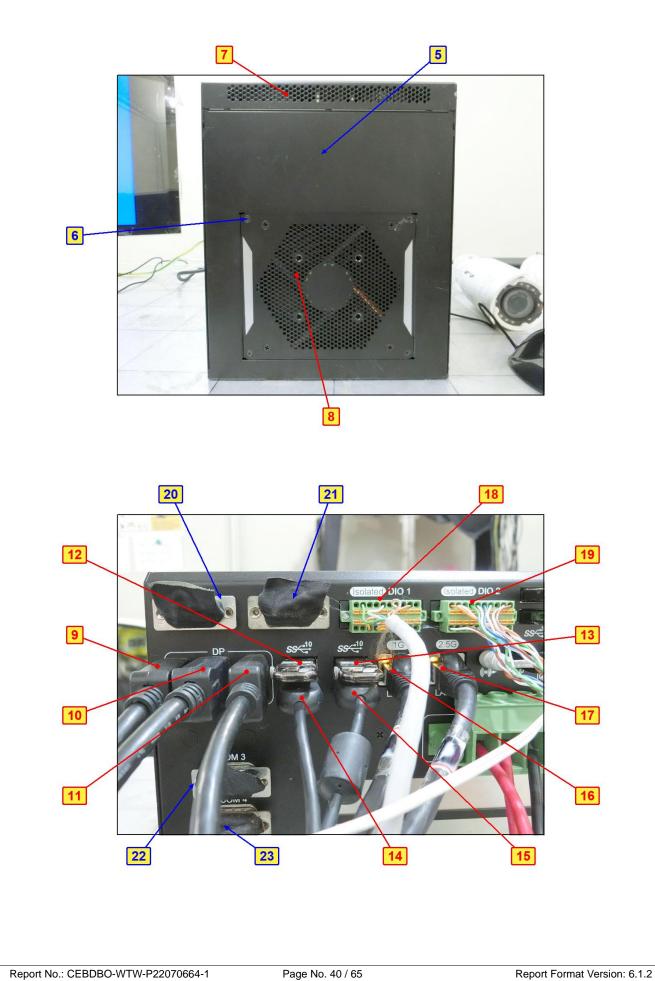
4. Left side

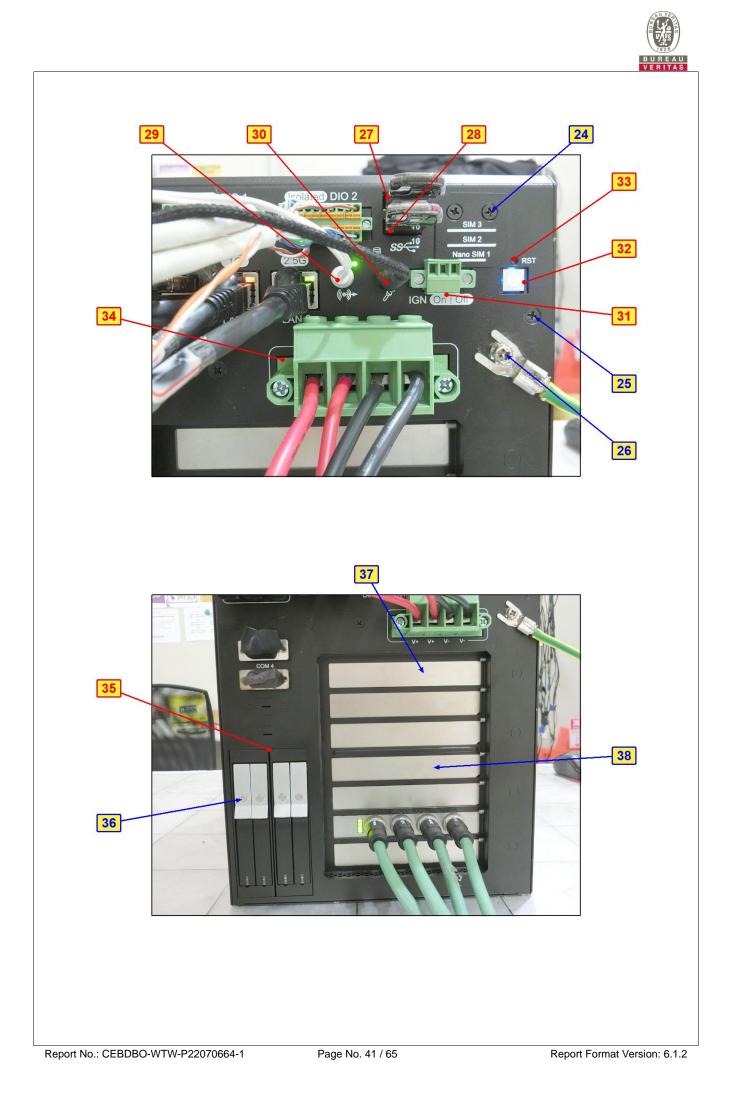
Note: 1. The EUT is operated normal during the test.

2. There are flicker on the Display screen, but auto recover after test

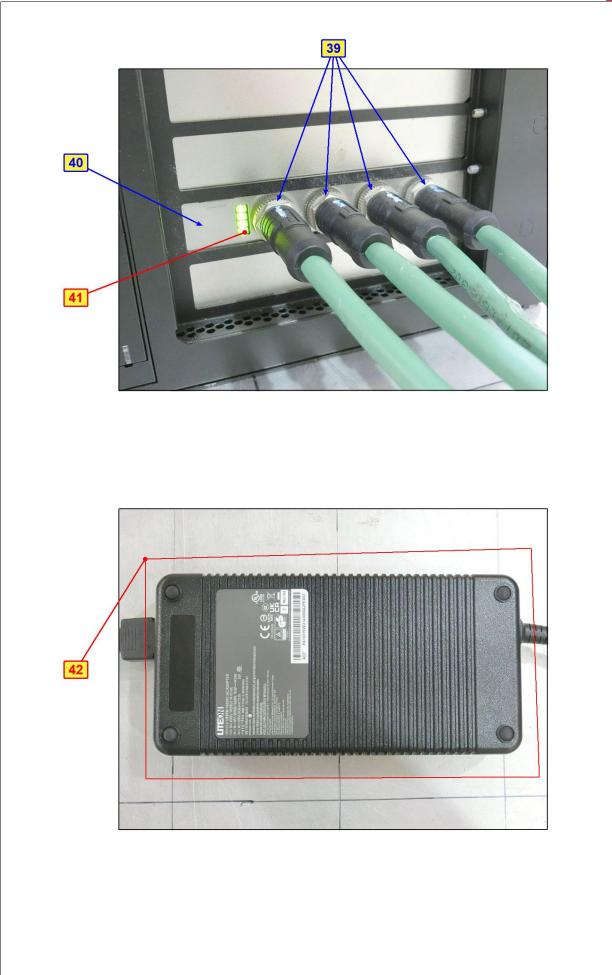












11 Radio-frequency Electromagnetic Field Immunity Test (RS)

11.1 Test Specification

Basic Standard:	EN 61000-4-3			
	80-800 MHz, 20V/m ¹			
Fraguency Bongo, Field	800-1000 MHz, 20V/m			
Frequency Range, Field Strength:	1400-2000 MHz, 10V/m			
o long li	2000-2700 MHz, 5V/m			
	5100-6000 MHz, 3V/m			
Modulation:	1kHz Sine Wave, 80%, AM Modulation			
Frequency Step:	1 % of preceding frequency value			
Polarity of Antenna:	Horizontal and Vertical			
Antenna Height:	1.5m			
Dwell Time:	3 seconds			

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.



11.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Amplifier BONN	BSA 0125-800	1912556	N/A	N/A
Amplifier TESTQ	CBA 1G-275	T44344	N/A	N/A
Audio analyzer R&S	UPV	104565	2022/5/10	2023/5/9
Band pass filter B&K	WH3278	N/A	2021/11/17	2022/11/16
BiconiLog Antenna EMCO	3141	1001	N/A	N/A
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	2022/2/3	2023/2/2
Controller AR	SC1000M3	305910	N/A	N/A
Ear Simulator Telephonometry B&K	4185	2553594	N/A	N/A
High Gain Horn Antenna AR	AT4010	0329800	N/A	N/A
LOG ANTENNA Schwarzbeck	Schwarzbeck Stlp 9149	9149-260	N/A	N/A
Log-Periodic Antenna AR	AT6080	0329465	N/A	N/A
Power Amplifier	35S4G8AM4	0326094	N/A	N/A
AR	100S1G4M3	0329249	N/A	N/A
Power Meter BOONTON	4232A	94901	2022/6/6	2023/6/5
Power Sensor	51011-EMC	32807	2022/6/6	2023/6/5
BOONTON	51011-EIVIC	32832	2022/6/6	2023/6/5
Pressure-field Microphone B&K	4192	3190854	2021/12/20	2022/12/19
Signal Generator Agilent	E8257D	MY48050465	2022/6/29	2023/6/28
Software BVADT	RS_V7.6	N/A	N/A	N/A
Software	ABMS_ V7.4.3	N/A	N/A	N/A
Two channel microphone conditioning amplifier B&K	2690 OS2	3001996	2021/11/17	2022/11/16
Wireless Connection Tester R&S Notes:	CMW270	101075	2022/4/18	2023/4/17

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou RS Room No.02.

3. Tested Date: 2022/8/24



The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The frequency ranges and field strength levels are 80-800 MHz, 20V/m, 800-1000 MHz, 20V/m, 1400-2000 MHz, 10V/m, 2000-2700 MHz, 5V/m and 5100-6000 MHz, 3V/m with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

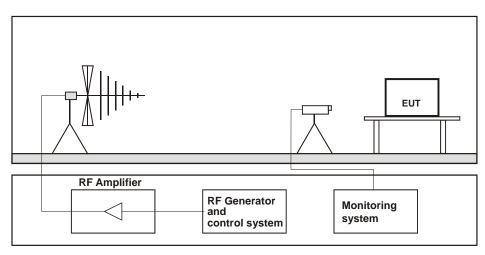


Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

11.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	24°C, 76% RH		

Frequency	Polarity	Polarity Azimuth(°)		ed Field Strength	Observation	Performance
(MHz)	Tolanty		(V/m)	Modulation	Observation	Criterion
80 - 800	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	А
800 - 1000	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	А
1400 - 2000	V&H	0, 90, 180, 270	10	80% AM (1kHz)	Note	A
2000 - 2700	V&H	0, 90, 180, 270	5	80% AM (1kHz)	Note	А
5100 - 6000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note	А

Note: The EUT is operated normal during the test.



12 Electrical Fast Transient/Burst Immunity Test (EFT)

12.1 Test Specification

Basic Standard:	EN 61000-4-4
Test Voltage:	Signal & communication, process measurement & control ports: $\pm 2kV$, Capacitive clamp Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms): $\pm 2kV$
Impulse Repetition Frequency:	5kHz
Impulse Wave Shape:	5/50 (T _r /T _h) ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	1 min.

12.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Burst generator Haefely	PEFT 4010	154954	2022/3/29	2023/3/28

Notes:

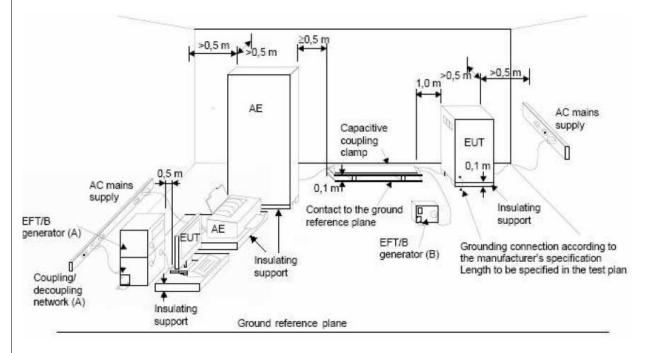
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou EFT Room.

3. Tested Date: 2022/8/26



- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN 61000-4-4, 5/50 ns.



NOTE:

(A) location for supply line coupling

(B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



12.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	23°C, 72% RH		

Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms)

	······································						
Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion			
2	L	+/-	Note	А			
2	N	+/-	Note	А			
2	PE	+/-	Note	А			
2	L-N-PE	+/-	Note	А			

Signal & communication, process measurement & control ports

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	LAN 1	+/-	Note	А
2	LAN 2	+/-	Note	А
2	LAN CARD Port 1	+/-	Note	А
2	LAN CARD Port 4	+/-	Note	А

Note: The EUT is operated normal during the test.



13 Surge Immunity Test

13.1 Test Specification

Basic Standard: Wave-Shape:	EN 61000-4-5 Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms): 1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current
Test Voltage:	Line to line: ±0.5kV, ±1kV, Line to ground: ±0.5kV, ±1kV, ±2kV output impedance of 42 Ω (40 Ω and 2 Ω generator) and a coupling capacitance of 0,5 μF
AC Phase Angle (degree):	0°, 90°, 180°, 270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

13.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
CDN for Unshielded Unsymmetrical Signal & Data Lines TESEQ	CDN117	40144	2022/8/23	2023/8/22
Coupling Decoupling Network EMC-Partner	CDN-UTP8	045	2022/8/2	2023/8/1
Coupling Decoupling Network TESEQ	CDN HSS-2	41009	2022/4/18	2023/4/17
Surge Coupling Decoupling Network TESEQ	CDN 118-T8	40386	2021/8/30	2022/8/29
Surge&EFT Generators TESEQ	NSG 3060	1572	2022/4/18	2023/4/17

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

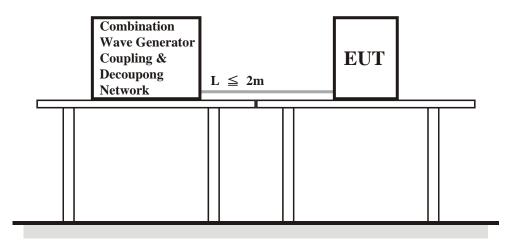
2. The test was performed in Linkou EMS Room No.02.

3. Tested Date: 2022/8/25



The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

13.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	24°C, 73% RH		

Battery referenced ports (except at the output of energy sources),

Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5, 1	L-N	+/-	Note	А
0.5, 1, 2	L-PE	+/-	Note	А
0.5, 1, 2	N-PE	+/-	Note	A

Note: The EUT is operated normal during the test.



14 Immunity to Conducted Disturbances Induced by RF Fields (CS)

14.1 Test Specification

Basic Standard:	EN 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms), Signal & communication, process measurement & control ports: 10 V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds

14.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Amplifier AR	75A250AM1	306331	N/A	N/A
Audio analyzer R&S	UPV	104565	2022/5/10	2023/5/9
CDN FCC	FCC-801-M5-50A	100018	2022/1/18	2023/1/17
CDN	CDN S200	53490	2022/2/24	2023/2/23
TESEQ	CDN S400	52115	2022/2/24	2023/2/23
CDN Calibration Kit TESEQ	CDN T8S	29459	2022/2/22	2023/2/21
CDN M2-16Amp FCC	FCC-801-M2-16A	01047	2022/2/23	2023/2/22
	CDN M432S	56519	2022/2/23	2023/2/22
		56435	2022/2/21	2023/2/20
	CDN S751A	56436	2022/2/22	2023/2/21
	CDN ST08A	56525	2022/2/21	2023/2/20
		56527	2022/2/21	2023/2/20
Coupling Decoupling Network	CDN T2A-10	54942	2022/2/22	2023/2/21
TESEQ	CDN T8-10	40376	2022/2/22	2023/2/21
		56641	2022/2/22	2023/2/21
	CDN T8-230	56642	2022/2/22	2023/2/21
		56643	2022/2/22	2023/2/21
	CDN T800	34428	2022/2/22	2023/2/21
	CDN T400A	49918	2022/2/23	2023/2/22
Coupling/Dcoupling Network EM TEST	CDN M1/32A	306508	2022/2/23	2023/2/22
	CDN M232	37702	2022/2/23	2023/2/22
Coupling/Dcoupling Network	CDN M332	41256	2022/2/23	2023/2/22
		41258	2022/2/23	2023/2/22
Current Clamp FCC	F-120-9A	361	2022/8/17	2023/8/16



Description Manufacturer	Model No. Serial No.		Calibrated Date	Calibrated Until
Digital Sweep Function Generator Topward	8120	984801		N/A
Ear Simulator Telephonometry B&K	4185	2553594	N/A	N/A
FCC EM Injection Clamp FCC	F-203I-23mm	455	N/A	N/A
Mouth Simulator B&K	4227	2630632	N/A	N/A
POWER AMPLIFIER B&K	2716C	2610979	N/A	N/A
Power Meter R & S	NRVD	837794/040	2021/10/19	2022/10/18
Power Sensor R & S	NRV-Z5	837878/039	2021/10/19	2022/10/18
Pressure-field Microphone B&K	4192	2735407	2021/11/19	2022/11/18
R&S SML03 S.G R&S	SML03	101801	2022/1/11	2023/1/10
Software	ABMS_ V7.4.3	N/A	N/A	N/A
BVADT	CS_V7.4.2	N/A	N/A	N/A
Two channel microphone conditioning amplifier B&K	2690 OS2	3001996	2021/11/17	2022/11/16
Wireless Connection Tester R&S	CMW270	101075	2022/4/18	2023/4/17

Notes:

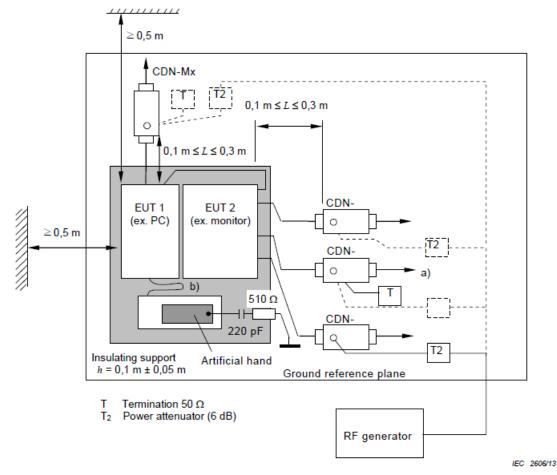
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou CS Room No.1.

3. Tested Date: 2022/8/22



- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



- Note: 1.The EUT clearance from any metallic obstacles shall be at least 0,5 m.
 - 2. Interconnecting cables (≤ 1 m) belonging to the EUT shall remain on the insulating support.
 - 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



14.4 Test Results

Mode A

Input Power 230Vac, 50 Hz		Tested by	Joey Liu
Environmental Conditions	onmental Conditions 23°C, 69% RH		

Frequency (MHz)	Level (V rms)	Tested Line	Injection Method	Return Path	Observation	Remark	Performance Criterion
0.15 – 80	10	AC Power	CDN-M3	CDN-ST08A	Note	-	A
0.15 – 80	10	LAN 1 (1G)	CDN-ST08A	CDN-M3	Note	-	A
0.15 – 80	10	LAN 2 (2.5G)	CDN-ST08A	CDN-M3	Note	-	А
0.15 – 80	10	LAN Card Port1	CDN-ST08A	CDN-M3	Note	-	А
0.15 – 80	10	LAN Card Port4	CDN-ST08A	CDN-M3	Note	-	А

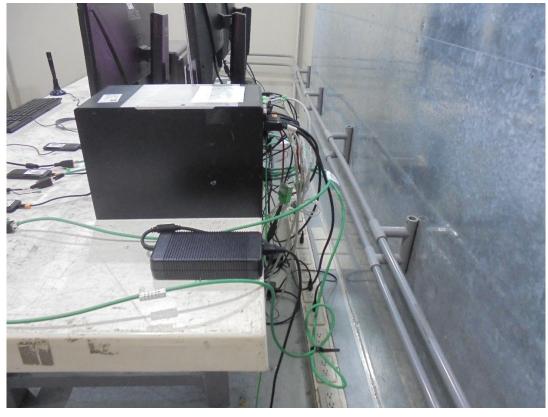
Note: The EUT is operated normal during the test.



15 Pictures of Test Arrangements

15.1 Conducted Disturbance at Auxiliary a.c. or d.c. power ports





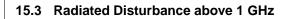
Report No.: CEBDBO-WTW-P22070664-1

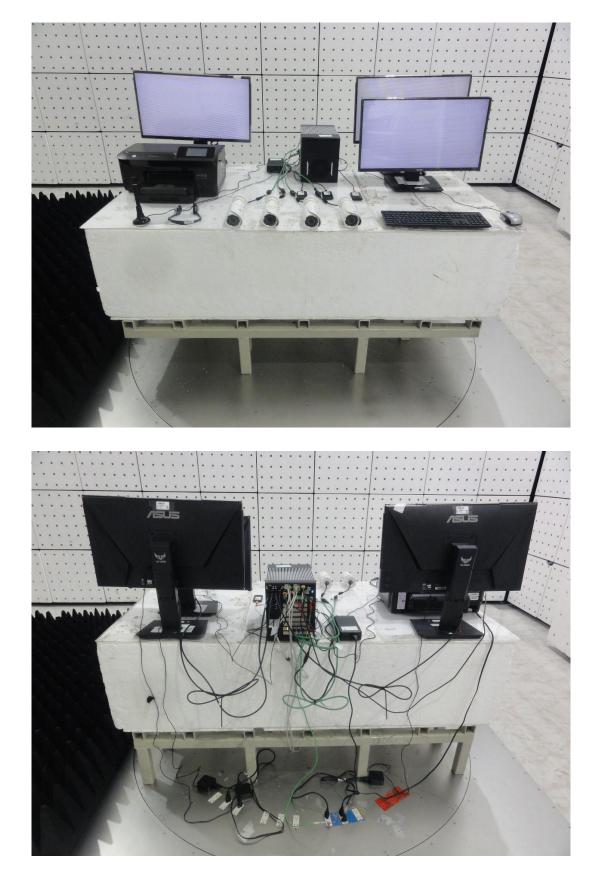


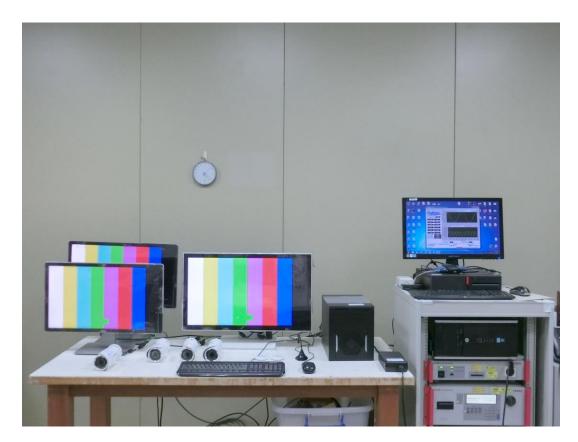
15.2 Radiated Disturbance up to 1 GHz











15.4 Harmonics Current, Voltage Fluctuations and Flicker Measurement

15.5 Electrostatic Discharge Immunity Test (ESD)



Report No.: CEBDBO-WTW-P22070664-1

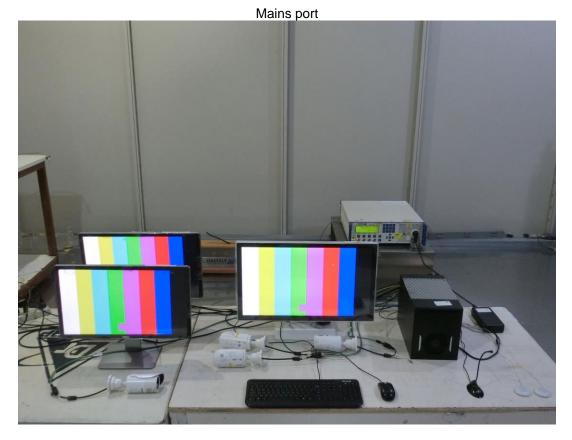


15.6 Radio-frequency Electromagnetic Field Immunity Test (RS)





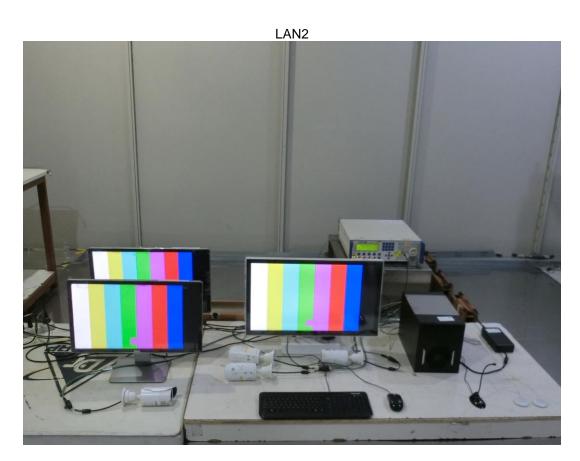
15.7 Fast Transients (EFT)



LAN1





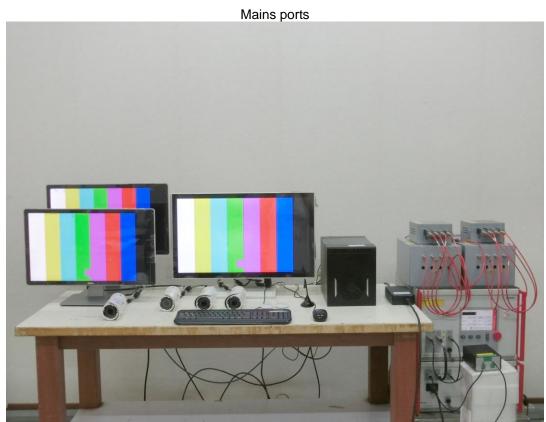


LAN Card



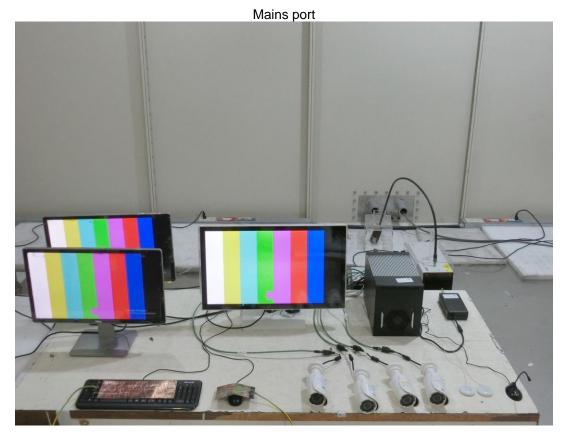


15.8 Surge

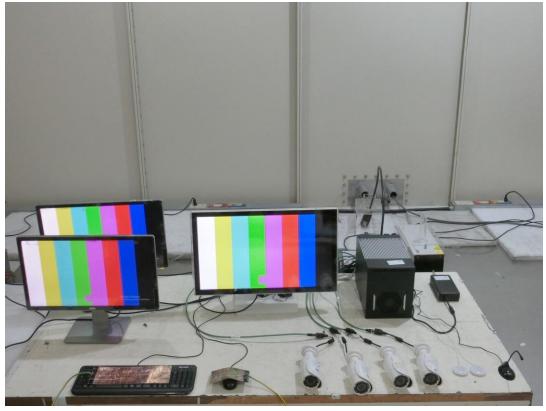


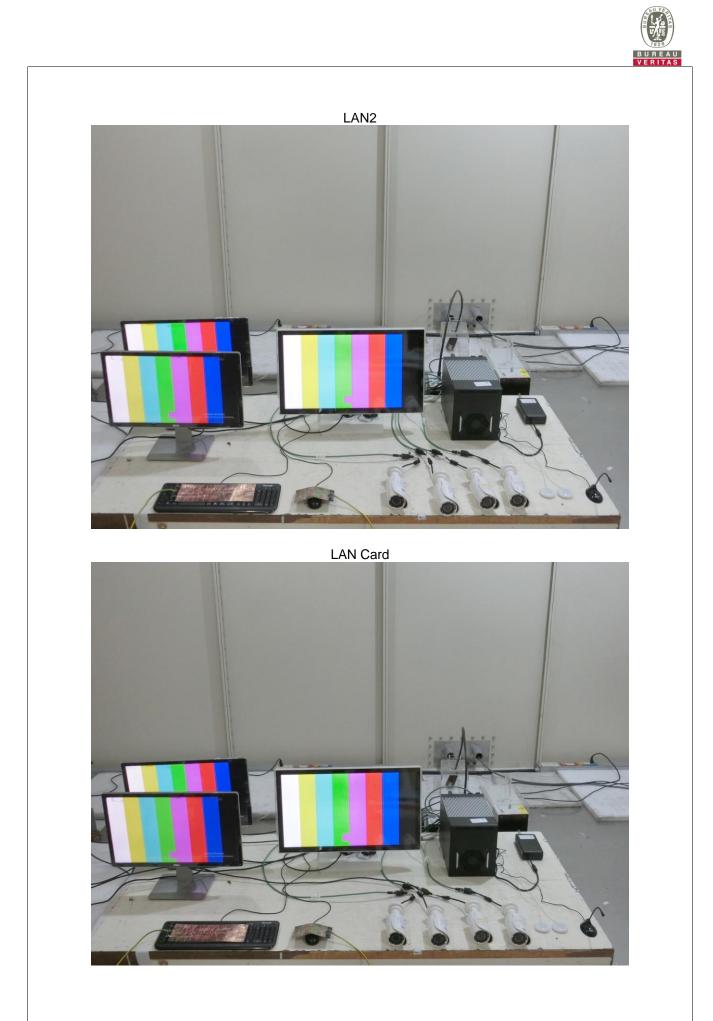


15.9 Radio-frequency common mode (CS)



LAN1







Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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The address and road map of all our labs can be found in our web site also.

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